

**Notice of References Cited**

Application/Control No.

10/566,446

Applicant(s)/Patent Under  
Reexamination  
LIM ET AL.

Examiner

Thao T. Tran

Art Unit

1794

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,260,696	04-1981	Blount, David H.	525/477
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	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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